

**MICROELECTRONICS & NEW MATERIALS: CHALLENGES & OPPORTUNITIES**

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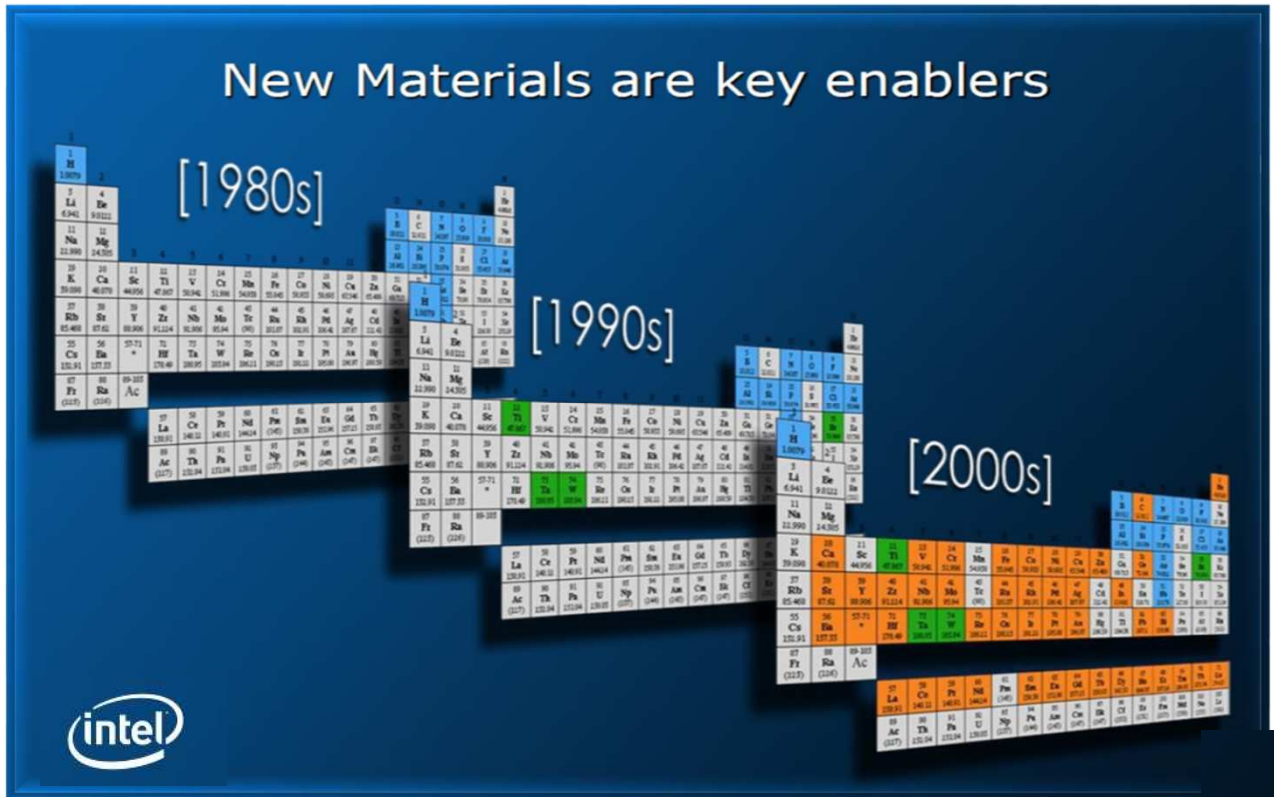




## OUTLINE

- Introduction – New Market Opportunities
- Integrating New Materials in the Process Flow
- Challenges and Opportunities
- Conclusions

# MICROELECTRONIC TECHNOLOGIES ARE GROWING THROUGH MATERIAL INNOVATION

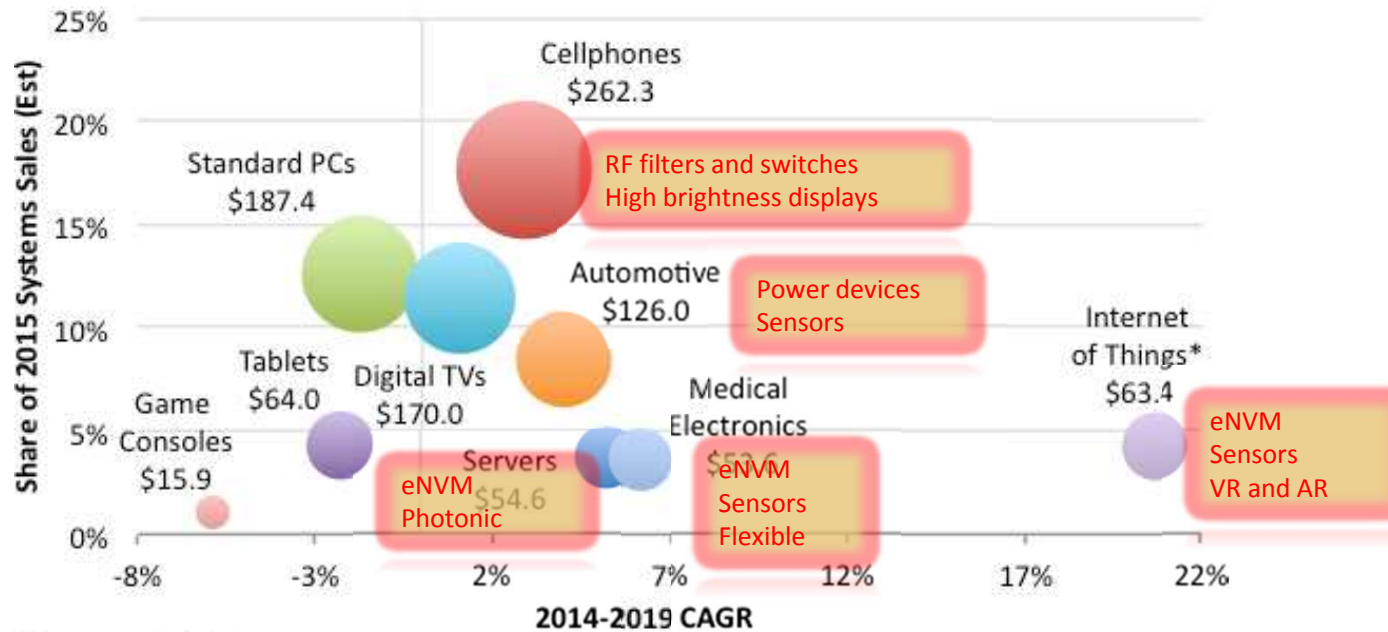


- New materials enable innovation by
- Improving performance
  - Opening new market opportunities



## NEW MARKET OPPORTUNITIES ARE DRIVEN BY SCALING AND ... NEW MATERIAL DEVICES

### End-Use Systems Markets (\$B) and Growth Rates



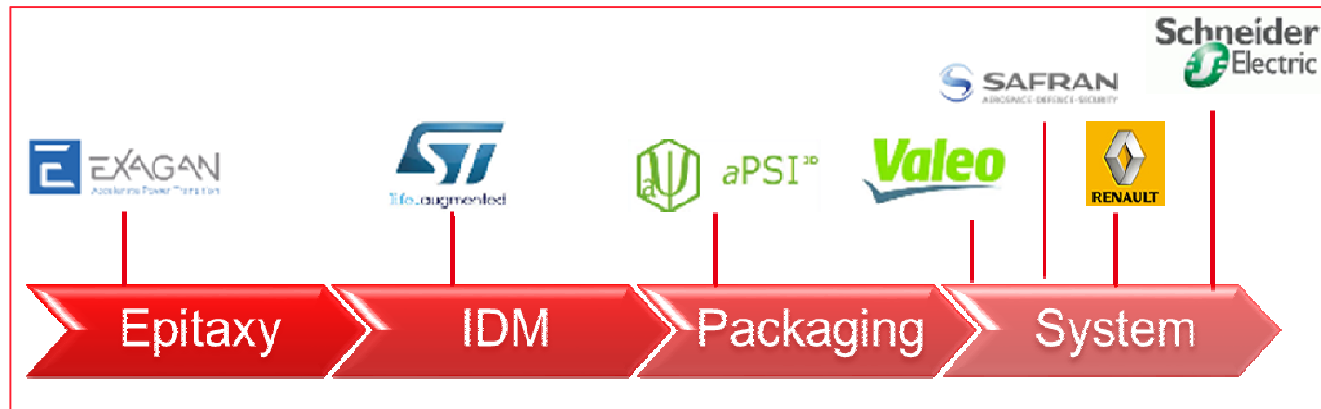
\*Covers only the Internet connection portion of systems

Source: IC Insights



## FROM MATERIALS TO SYSTEMS: AN INTEGRATED APPROACH

An example: Leti's Ecosystem in Power GaN



**Integration of New Materials in Process Flows is Key  
for Best-in-Class, Application-Specific Devices**



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## LETI'S APPROACH TO MATERIAL INTEGRATION

- Direct Material Deposition
- Material Chip-to-Wafer Transfer
- Full Material Transfer



## DIRECT MATERIAL DEPOSITION

### ■ Benefits

- ✓ Simple
- ✓ Cheap

### ■ Drawbacks

- ✓ Thermal Budget Limitation
- ✓ Heterogeneous Epitaxy Availability

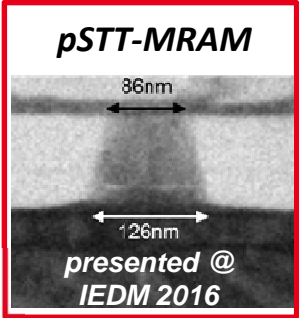
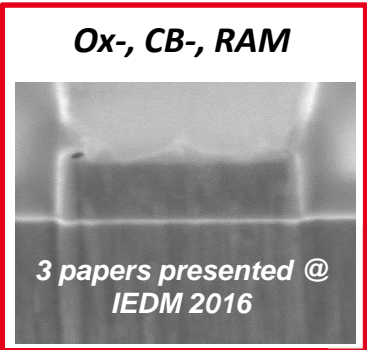






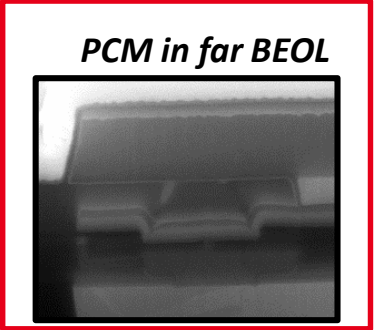
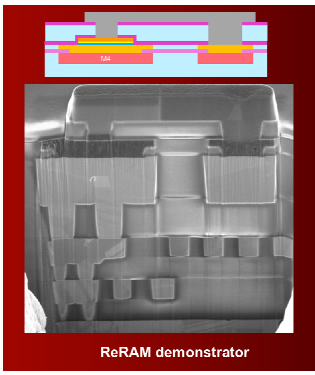
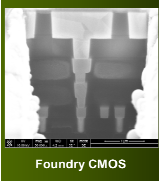
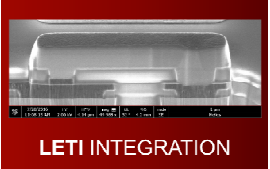
# NVM MATERIAL DEVELOPMENT: IMPLEMENTING DIRECT MATERIAL DEPOSITION

- Target for 2017:  
to include a  
**BEOL selector**



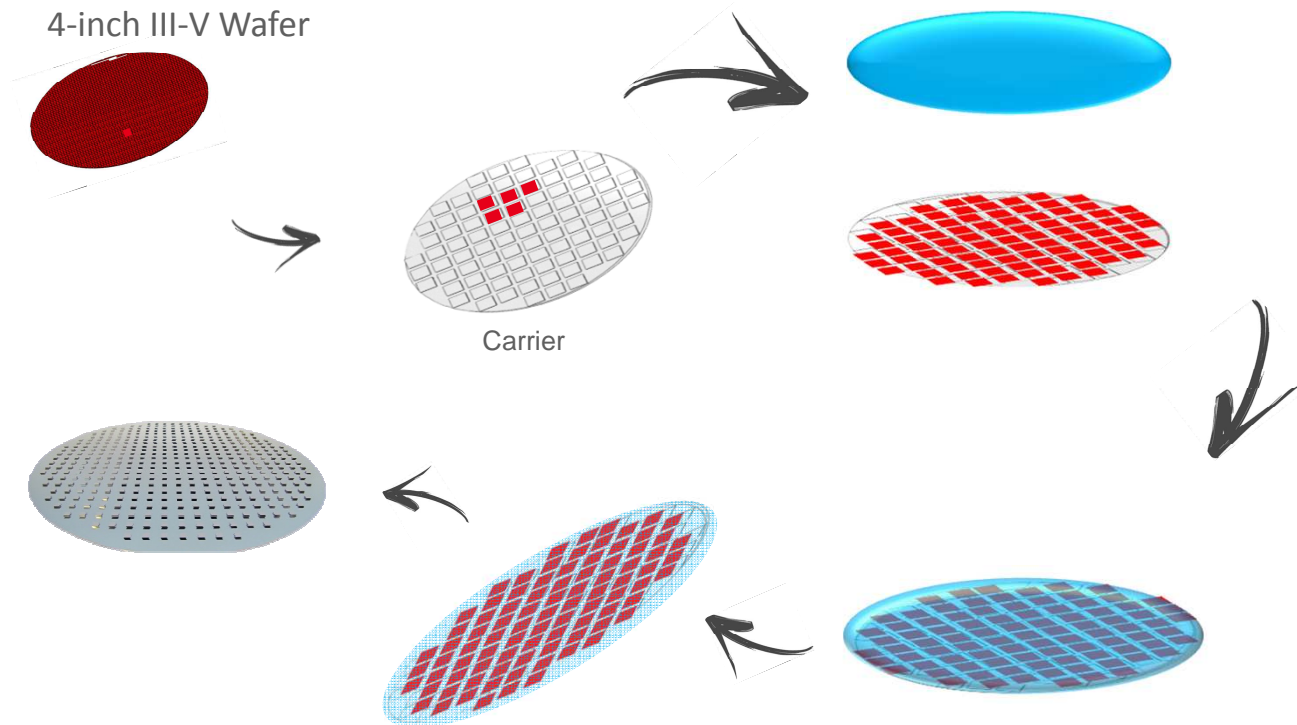
Project/Partner specific: NVM  
module plus 2 metal layers  
**fabricated at Leti**

Common CMOS test wafer,  
commercially outsourced,  
with 4 metal layers  
and all circuit test structures





## MATERIAL CHIP-TO-WAFER TRANSFER



### Benefits

- ✓ Material cost efficiency
- ✓ Use of available epi wafers (4 - 6 inch)

### Drawbacks

- ✓ Limited to 10% surface usage (cost)
- ✓ Complex integration

# PHOTONIC INTEGRATED CIRCUITS: AN IMPLEMENTATION OF CHIP-TO-WAFER INTEGRATION

## Objectives

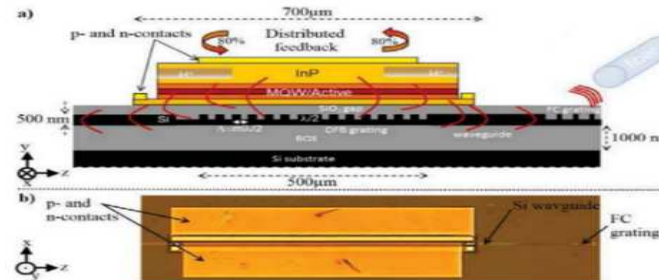
- Integration of III-V lasers on a Silicon photonic circuit

## Requirements

- Full integration in 200/300mm fab
- Precise control of III-V quantum well/Si waveguide interface
- Laser processing on CMOS line

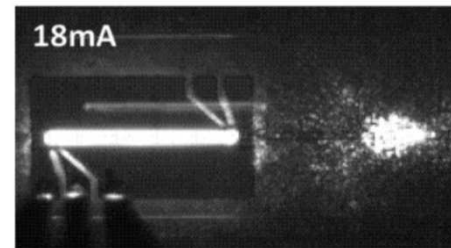
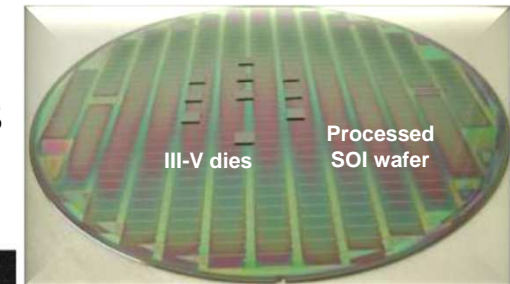
## One solution: Collective direct bonding of InP dies on Si wafers

- Collective processes w/o any glue layer



Heterogeneously integrated III-V on silicon distributed feedback lasers

InP-dies bonded on Silicon CMOS wafer using direct bonding



## FULL SUBSTRATE MATERIAL TRANSFER



### ■ Benefits

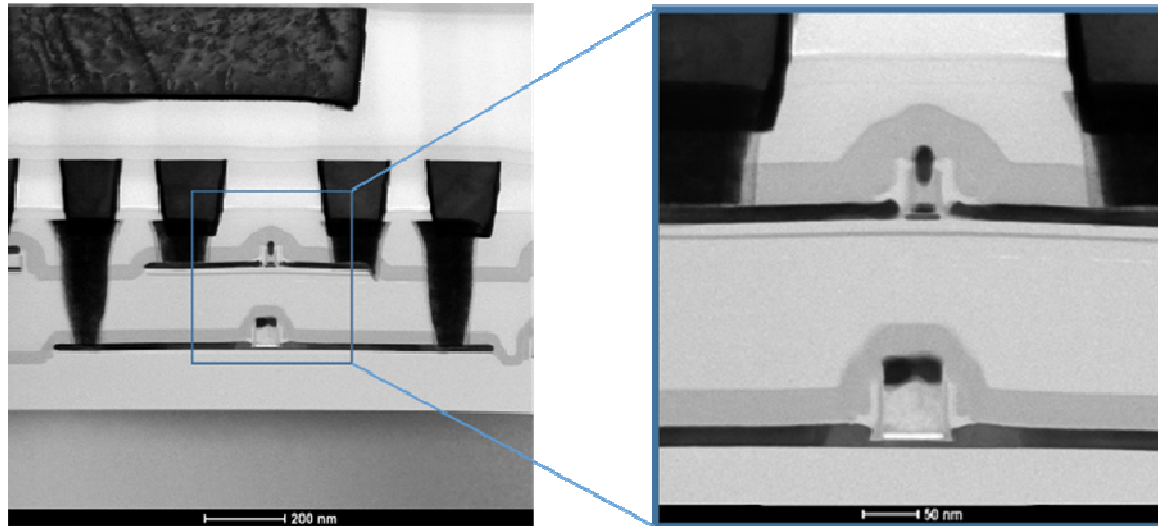
- ✓ No thermal budget limitation
- ✓ Heterogeneous epitaxy capability

### ■ Drawbacks

- ✓ Mastering of bonding processes and carrier release



## COOLCUBE PROCESS FLOW: 3D MONOLITHIC INTEGRATION AN IMPLEMENTATION OF FULL MATERIAL TRANSFER INTEGRATION



*L Brunet, VLSI 2016*

- ✓ Nanometric lithography alignment at wafer scale
- ✓ No impact of layer deformation during bonding and thinning



## OUTLINE

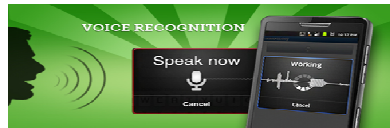
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## 3 CHALLENGES IN MATERIAL INTEGRATION FOR MORE THAN MOORE APPLICATIONS

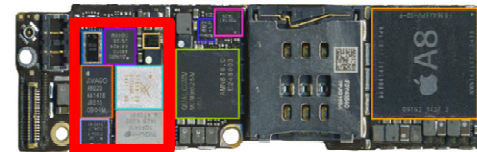
- Piezoelectric Materials for New Sensor/Actuator Applications

### High-SNR Microphone



Voice recognition for biometrics market

- Materials for 5G RF Filtering Functions



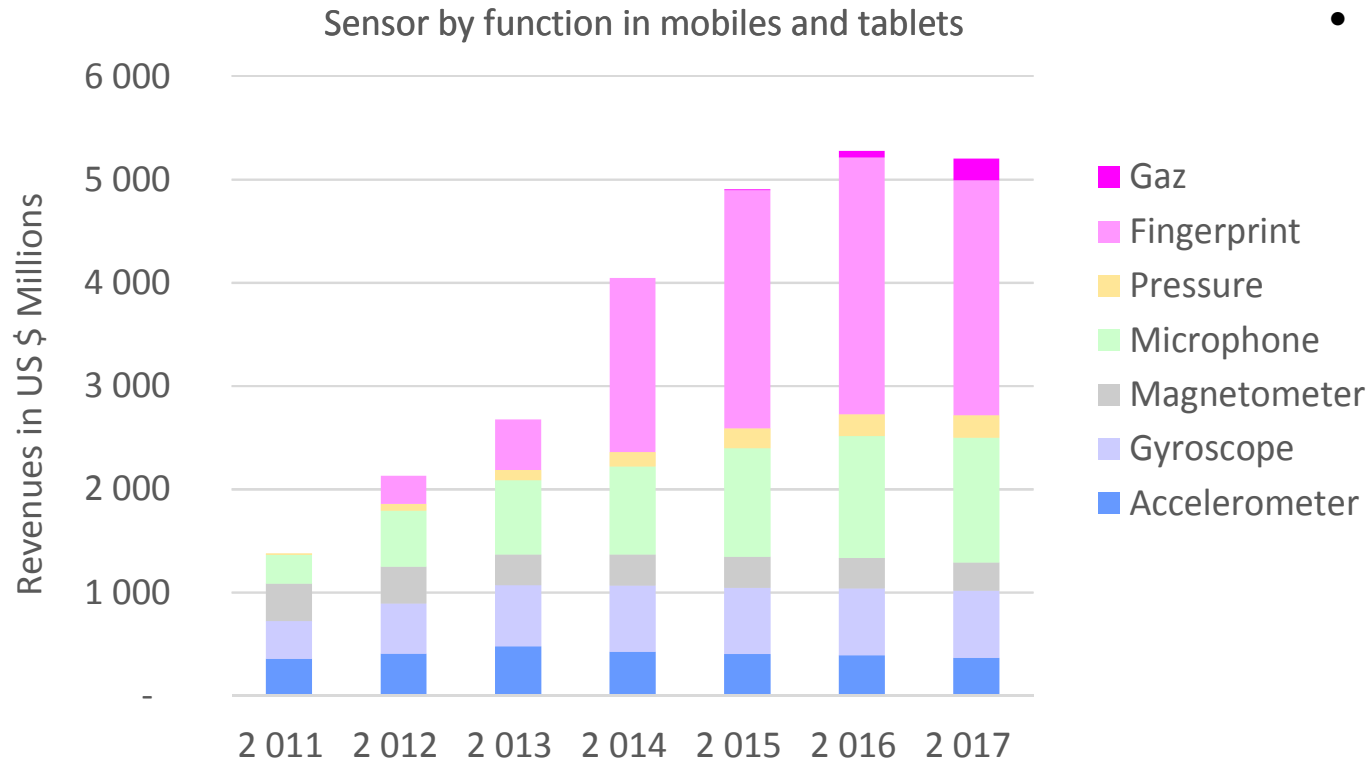
Cellular RF FEM

- III-V Materials for AR/VR Applications





## MARKET OPPORTUNITIES FOR PIEZO-MEMS



Market report and forecast – data from IHS reports on sensors for mobile phone and tablets 2014

- FingerPrint  
 
- Microphones  

- Ultrasonic Sensors  

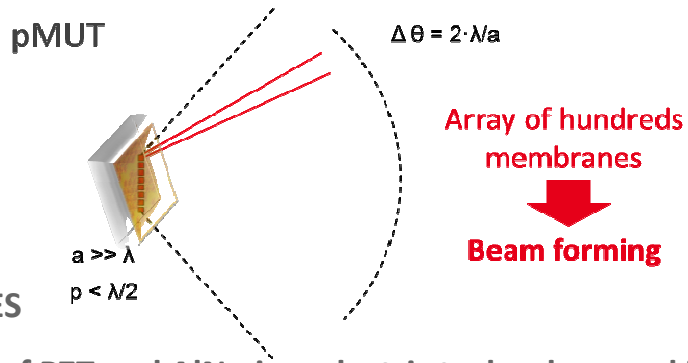
- Integrated Optic  

- Inkjet  

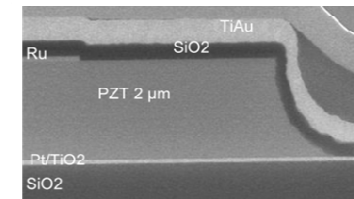





# PIEZO MATERIALS FOR PMUT ARRAYS @LETI



(pMUT array)



## CHALLENGES

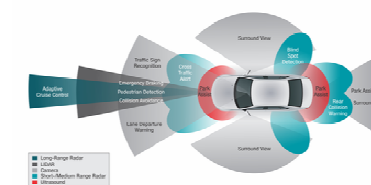
- Well control of PZT and AlN piezoelectric technology and integration
- Demonstration of high-frequency piezoelectric actuation and detection
- 3D integration with read/write electronics



Ultrasonic gesture recognition



Imaging and biological monitoring



Ranging / obstacle avoidance:  
Autonomous vehicles, Robotics, Drones



## 5G MOBILE MARKET

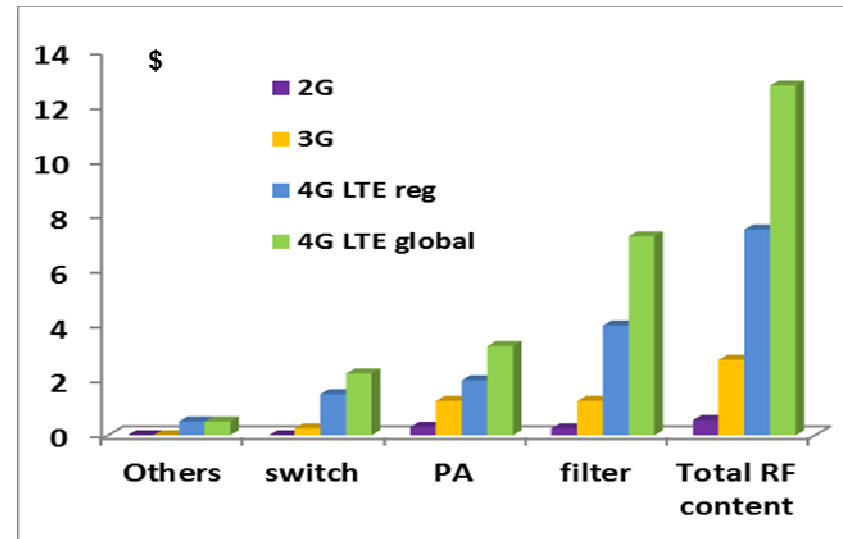
### LARGE INCREASE OF RF FUNCTIONS IN MOBILE PHONES DUE TO EVOLUTION OF COMMUNICATION STANDARDS

#### 4G smartphone today :

Band Count > 15  
TX/RX filters > 30  
Switch Throw Count ~10

#### 4G/5G smartphone in the Future (LTE advanced) :

Band Count > 30  
TX/RX filters > 75  
Switch Throw Count > 30

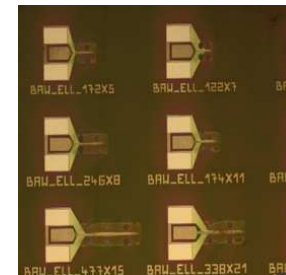
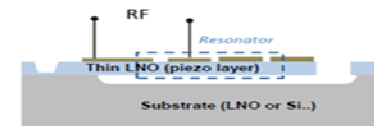
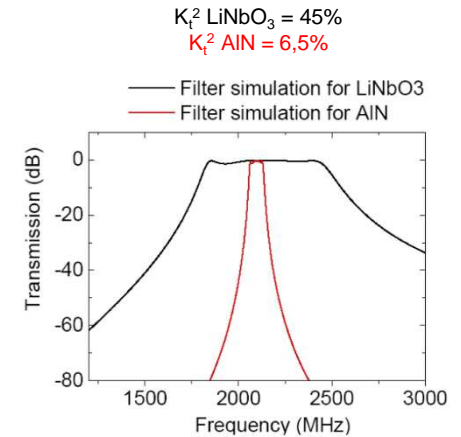


## CHALLENGES

- High-performance resonator technology bandwidth
- Reconfigurable filters and PA
- Increasing the coupling coefficient ( $kT^2$ ): AIN  $\rightarrow$  LNO

## SOLUTIONS

- Thin LNO on top of a cavity using **full substrate material transfer technology**
- Two options: SAW, BAW
- Generic process on thin LNO, targeting different frequency bands (up to 6 GHz)

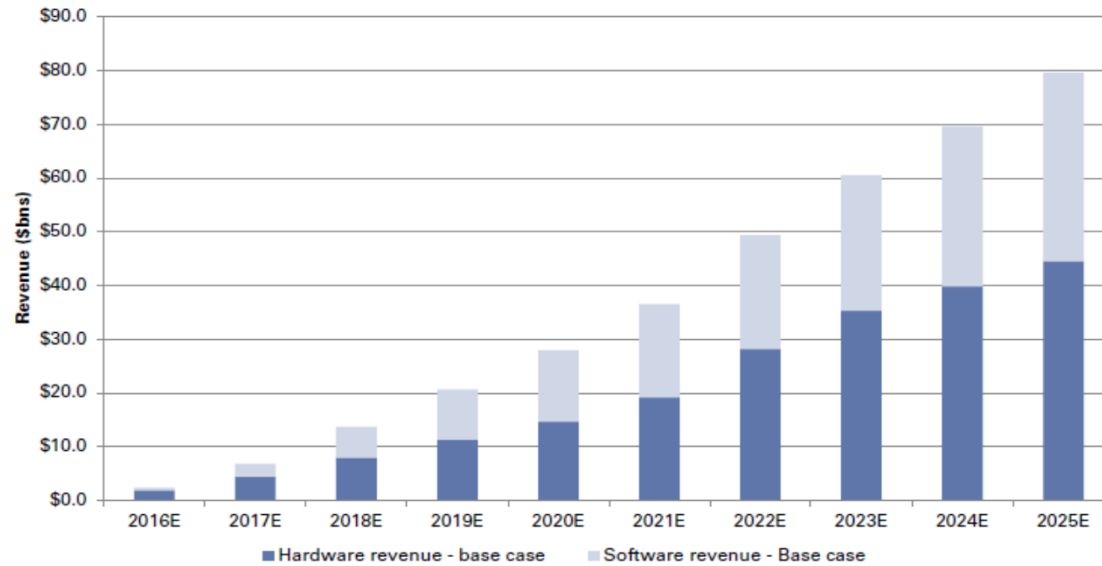




## AR/VR MARKET OPPORTUNITIES

### ■ Main Challenges for Microdisplays

#### ➤ Brightness and Resolution



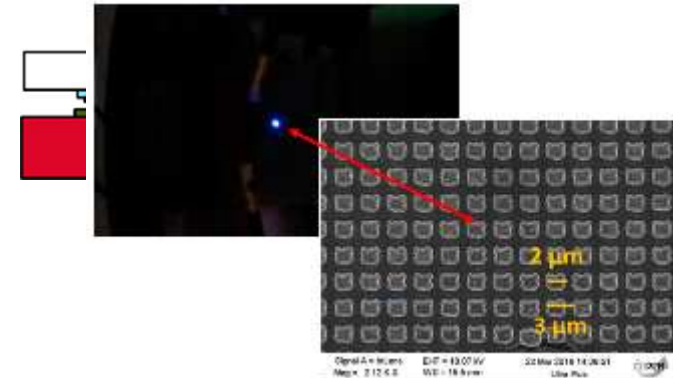
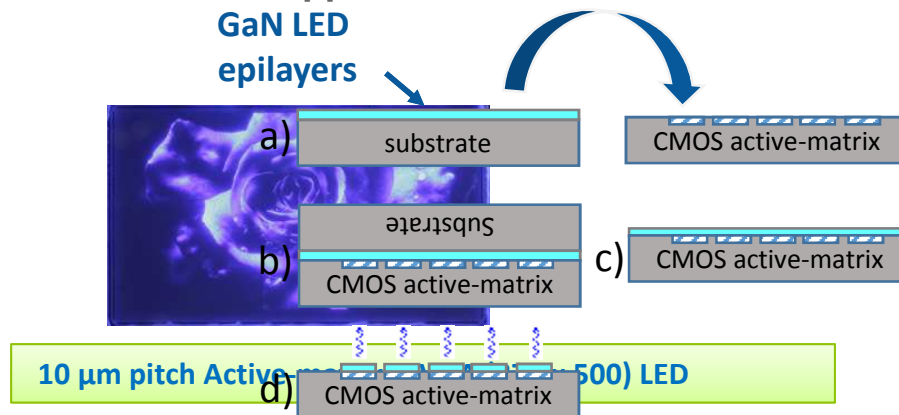
Source: Goldman Sachs Global Investment Research

## CHALLENGES

- Integration of GaN materials on CMOS wafers for high brightness
- Fine pitch

## SOLUTIONS

- First approach: hybrid interconnection of processed GaN wafer on CMOS wafer
- Novel approach: **Full GaN Substrate Transfer Technology**





## CONCLUSIONS

- New market opportunities will be driven by the introduction of new materials and innovative material integration technologies
- Leti is a leader in new material development and full integration processes (from concept to demonstration) that enable new applications thanks to innovative devices
- Leti is connected to industrial partners over the entire value chain
- There are many opportunities to collaborate (from equipment manufacturers, fabless and IDMs to end users) to innovate and provide solutions



## NEW MATERIAL VS APPLICATIONS

	III V	Piezo	Magnetic	Chalcogenide
Display	X			